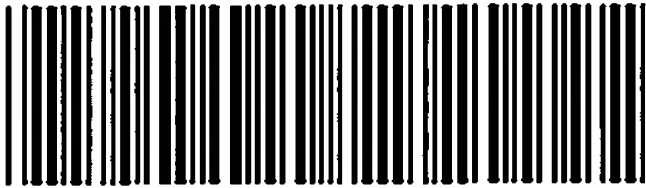


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/657,151	SEKI ET AL.	
	Examiner	Art Unit	
	Toan Ton	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	42-43	3/7/2005	TTON
	113		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST thin film transistor pixel contact hole/opening reflect\$ diffus\$, scatter\$ interlayer\$ insulat\$ recess\$, protrusion	3/7/2005	TTON